

**Search Notes**

Application/Control No.

10/665,654

Examiner

Linh M. Nguyen

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2816

**SEARCHED**

Class	Subclass	Date	Examiner
327	261	02/17/05	LMN
"	263	"	"
"	264	"	"
"	268	"	"
"	288	"	"
"	290	"	"
365	233	"	"

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR